

Notice of References Cited	Application/Control No. 10/003,439	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner Rutao Wu	Art Unit 3639	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,241,464 A	08-1993	Greulich et al.	705/26
	B	US-5,299,305 A	03-1994	Oomae et al.	715/506
	C	US-5,317,646 A	05-1994	Sang et al.	382/175
	D	US-5,570,291 A	10-1996	Dudle et al.	700/95
	E	US-5,870,717 A	02-1999	Wiecha, Charles Francis	705/26
	F	US-6,076,080 A	06-2000	Morscheck et al.	705/400
	G	US-2001/0013014 A1	08-2001	Fukumuro, Koichi	705/26
	H	US-2001/0042028 A1	11-2001	Yoshida, Takehiko	705/27
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.